

Notice of References Cited	Application/Control No. 10/605,920	Applicant(s)/Patent Under Reexamination HUANG ET AL.	
	Examiner Timothy L. Rude	Art Unit 2883	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,454,452	09-2002	Sasagawa et al.	362/561
*	B	US-6,647,199	11-2003	Pelka et al.	385/146
*	C	US-6,844,823	11-2003	Egawa et al.	362/609
*	D	US-6,206,535	03-2001	Hattori et al.	362/616
*	E	US-6,379,016	04-2002	Boyd et al.	362/625
*	F	US-6,480,307	11-2002	Yang, Keun-Chang	359/15
*	G	US-5,737,044	04-1998	Van Haaren et al.	349/61
*	H	US-6,474,827	11-2002	Shinohara et al.	362/607
*	I	US-5,050,946	09-1991	Hathaway et al.	385/33
*	J	US-4,252,416	02-1981	Jaccard, Pierre E.	349/65
*	K	US-5,202,950	04-1993	Arego et al.	385/146
*	L	US-5,914,760	06-1999	Daiku, Yasuhiro	349/65
*	M	US-6,755,460	06-2004	Marrs et al.	296/187.12

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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